

MOSFET

OptiMOS[™]5 Power-Transistor, 80 V

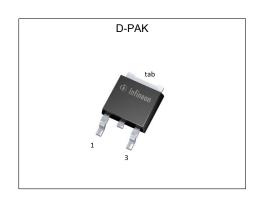
Features

- N-channel, normal level

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 Excellent gate charge x R_{DS(on)} product (FOM)
 Very low on-resistance R_{DS(on)}
 175 °C operating temperature
 Pb-free lead plating; RoHS compliant
 Qualified according to JEDEC¹⁾ for target application
 Ideal for high-frequency switching and synchronous rectification
 Halogen-free according to IEC61249-2-21



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Parameter	Value	Unit				
$V_{ m DS}$	80	V				
R _{DS(on),max}	4.6	mΩ				
I _D	90	A				











Type / Ordering Code	Package	Marking	Related Links
IPD046N08N5	PG-TO252-3	046N08N	-

OptiMOSTM5 Power-Transistor, 80 V IPD046N08N5



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OptiMOS[™]5 Power-Transistor, 80 V . IPD046N08N5



1 Maximum ratings at T_A =25 °C, unless otherwise specified

Table 2 Maximum ratings

Davamatav	Cumbal		Value	s	1114	Note / Took Constition
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Continuous drain current	I _D	-	-	90 82	А	T _C =25 °C ¹⁾ T _C =100 °C
Pulsed drain current ¹⁾	I _{D,pulse}	-	-	360	Α	<i>T</i> _C =25 °C
Avalanche energy, single pulse ²⁾	E AS	-	-	75	mJ	$I_{\rm D}$ =90 A, $R_{\rm GS}$ =25 Ω
Gate source voltage	V _{GS}	-20	-	20	V	-
Power dissipation	P _{tot}	-	-	125	W	<i>T</i> _C =25 °C
Operating and storage temperature	T _j , T _{stg}	-55	-	175	°C	IEC climatic category; DIN IEC 68-1: 55/175/56

2 Thermal characteristics

Table 3 Thermal characteristics

Dovomotov	Cumbal	Values			Unit	Note / Test Condition
Parameter	Symbol	Min.	Тур.	Max.	Ullit	Note / Test Condition
Thermal resistance, junction - case	R _{thJC}	-	0.7	1.2	K/W	-
Thermal resistance, junction - ambient, minimal footprint	R _{thJA}	_	-	75	K/W	-
Thermal resistance, junction - ambient, 6 cm² cooling area³)	R _{thJA}	-	-	50	K/W	-
Soldering temperature, wave and reflow soldering allowed	T _{sold}	-	-	260	°C	reflow MSL1

See Diagram 3 for more detailed information
 See Diagram 13 for more detailed information
 Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm² (one layer, 70 μm thick) copper area for drain connection. PCB is vertical in still air.

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3 Electrical characteristics

Table 4 Static characteristics

Parameter	0	Values				
	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Drain-source breakdown voltage	V _{(BR)DSS}	80	-	-	V	V _{GS} =0 V, I _D =1 mA
Gate threshold voltage	$V_{\rm GS(th)}$	2.2	3.0	3.8	V	$V_{\rm DS}$ = $V_{\rm GS}$, $I_{\rm D}$ =65 μA
Zero gate voltage drain current	I _{DSS}	-	0.1 10	1 100	μΑ	V _{DS} =80 V, V _{GS} =0 V, T _j =25 °C V _{DS} =80 V, V _{GS} =0 V, T _j =125 °C
Gate-source leakage current	I _{GSS}	-	1	100	nA	V _{GS} =20 V, V _{DS} =0 V
Drain-source on-state resistance	R _{DS(on)}	-	4.0 5.4	4.6 6.3	mΩ	V _{GS} =10 V, I _D =45 A V _{GS} =6 V, I _D =23 A
Gate resistance ¹⁾	R _G	-	1.1	1.7	Ω	-
Transconductance	g fs	41	82	-	S	$ V_{DS} > 2 I_D R_{DS(on)max}, I_D = 45 A$

Table 5 Dynamic characteristics¹⁾

Parameter	Cymph al		Values			
	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Input capacitance	C _{iss}	-	2930	3800	pF	V _{GS} =0 V, V _{DS} =40 V, f=1 MHz
Output capacitance	Coss	-	488	630	pF	V _{GS} =0 V, V _{DS} =40 V, f=1 MHz
Reverse transfer capacitance	C _{rss}	-	23	40	pF	V _{GS} =0 V, V _{DS} =40 V, <i>f</i> =1 MHz
Turn-on delay time	$t_{\sf d(on)}$	-	11	-	ns	$V_{\rm DD}$ =40 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =45 A, $R_{\rm G,ext}$ =1.6 Ω
Rise time	t _r	-	6	-	ns	$V_{\rm DD}$ =40 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =45 A, $R_{\rm G,ext}$ =1.6 Ω
Turn-off delay time	$t_{\sf d(off)}$	-	21	-	ns	$V_{\rm DD}$ =40 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =45 A, $R_{\rm G,ext}$ =1.6 Ω
Fall time	t _f	-	6	-	ns	$V_{\rm DD}$ =40 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =45 A, $R_{\rm G,ext}$ =1.6 Ω

Table 6 Gate charge characteristics²⁾

Parameter	Symbol	Values			Unit	Note / Test Condition
Farameter		Min.	Тур.	Max.	Ullit	Note / Test Condition
Gate to source charge	Q _{gs}	-	14	-	nC	V _{DD} =40 V, I _D =45 A, V _{GS} =0 to 10 V
Gate to drain charge ¹⁾	Q_{gd}	-	9	14	nC	V_{DD} =40 V, I_{D} =45 A, V_{GS} =0 to 10 V
Switching charge	Q _{sw}	-	14	-	nC	V _{DD} =40 V, I _D =45 A, V _{GS} =0 to 10 V
Gate charge total ¹⁾	Qg	-	42	53	nC	V _{DD} =40 V, I _D =45 A, V _{GS} =0 to 10 V
Gate plateau voltage	V _{plateau}	-	4.8	-	V	V _{DD} =40 V, I _D =45 A, V _{GS} =0 to 10 V
Output charge ¹⁾	Qoss	-	51	68	nC	V _{DD} =40 V, V _{GS} =0 V

 $^{^{1)}}$ Defined by design. Not subject to production test $^{2)}$ See "Gate charge waveforms" for parameter definition

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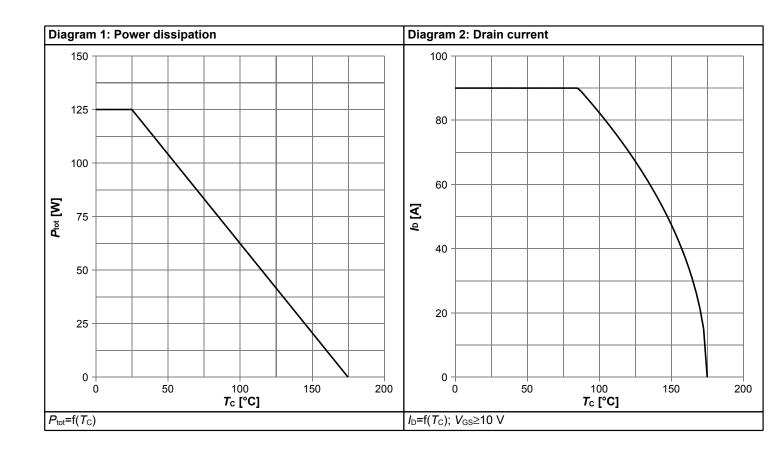


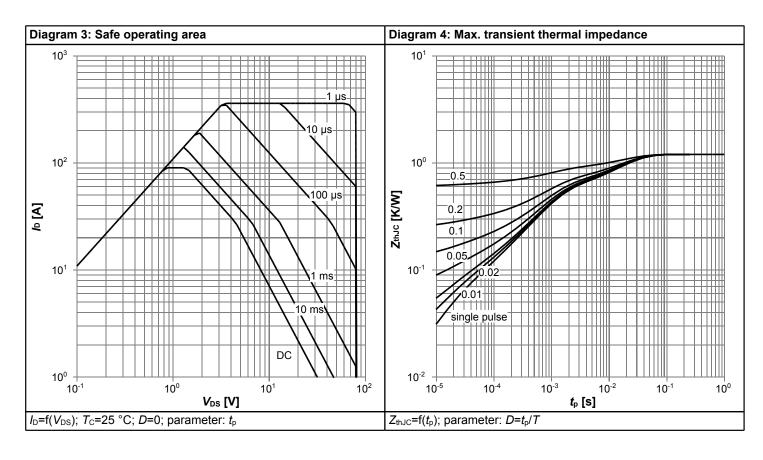
Table 7 Reverse diode

Parameter	Cymahal		Values			Note / Took Condition
	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Diode continous forward current	Is	-	-	90	Α	<i>T</i> _C =25 °C
Diode pulse current	I _{S,pulse}	-	-	360	Α	<i>T</i> _C =25 °C
Diode forward voltage	V _{SD}	-	0.9	1.2	V	V _{GS} =0 V, I _F =45 A, T _j =25 °C
Reverse recovery time ¹⁾	<i>t</i> _{rr}	-	41	82	ns	V _R =40 V, I _F =45, di _F /dt=100 A/μs
Reverse recovery charge ¹⁾	Qrr	-	46	92	nC	V _R =40 V, I _F =45, di _F /dt=100 A/μs

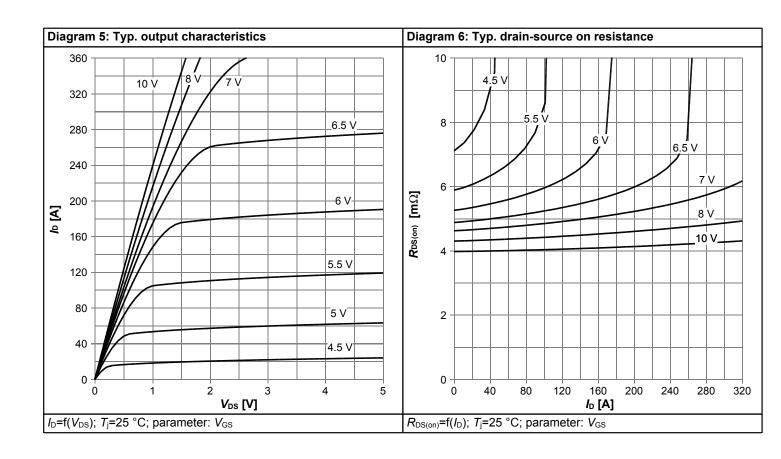


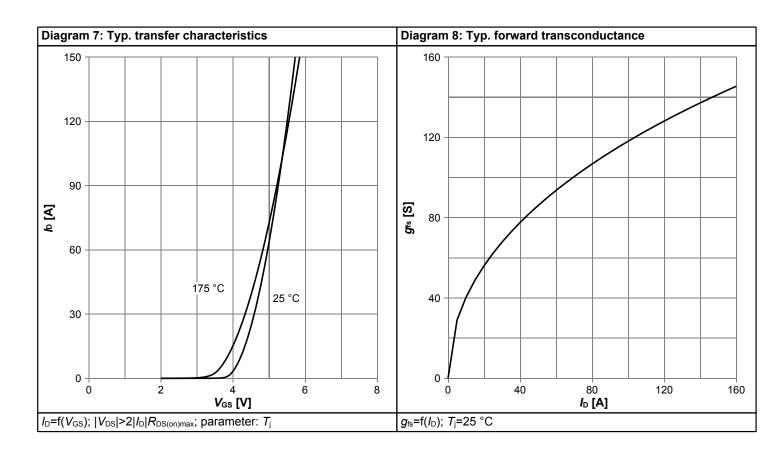
4 Electrical characteristics diagrams



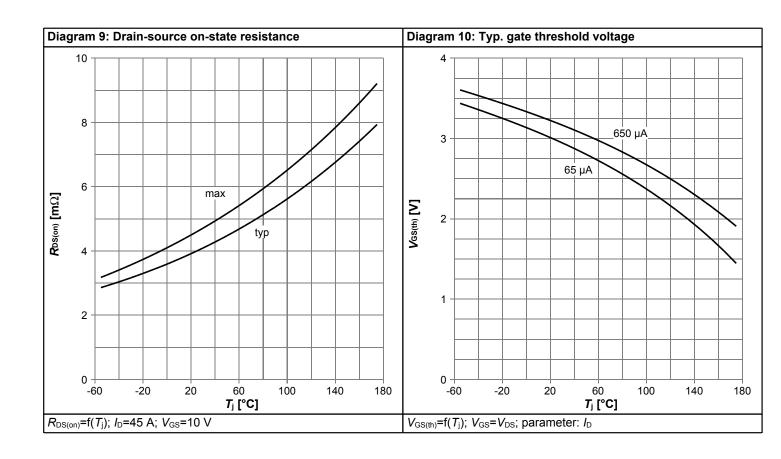


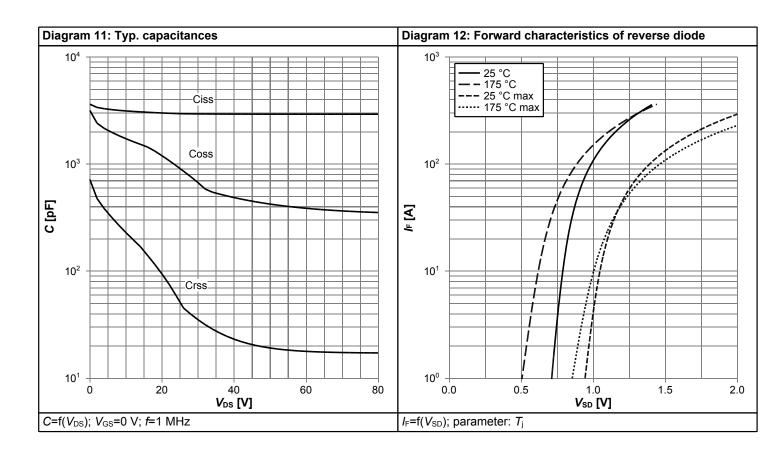




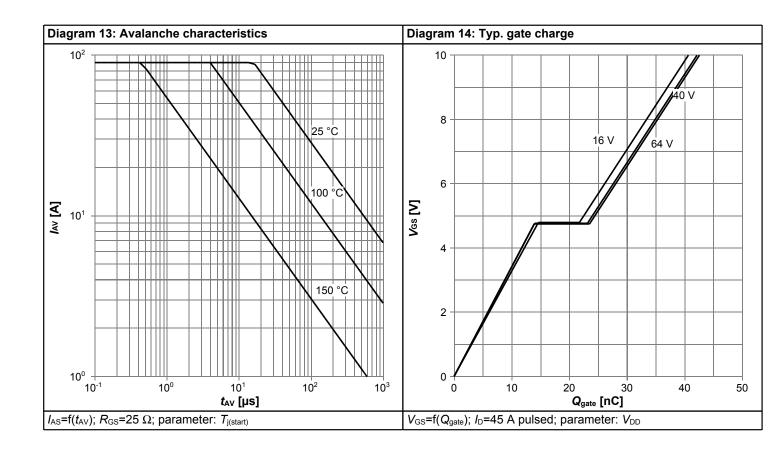


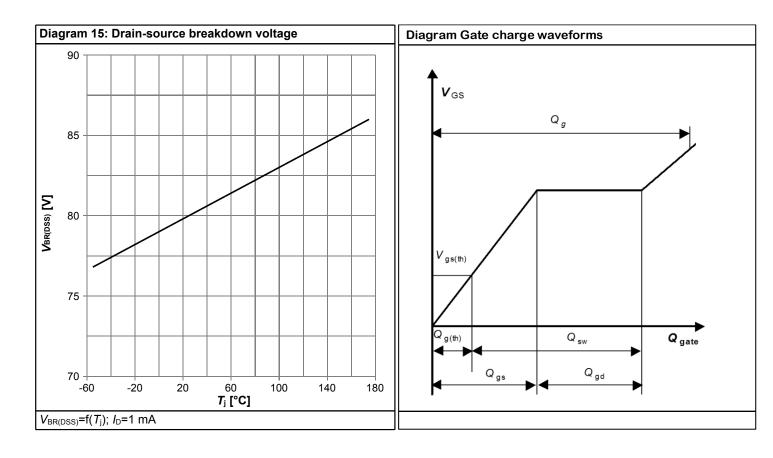














5 Package Outlines

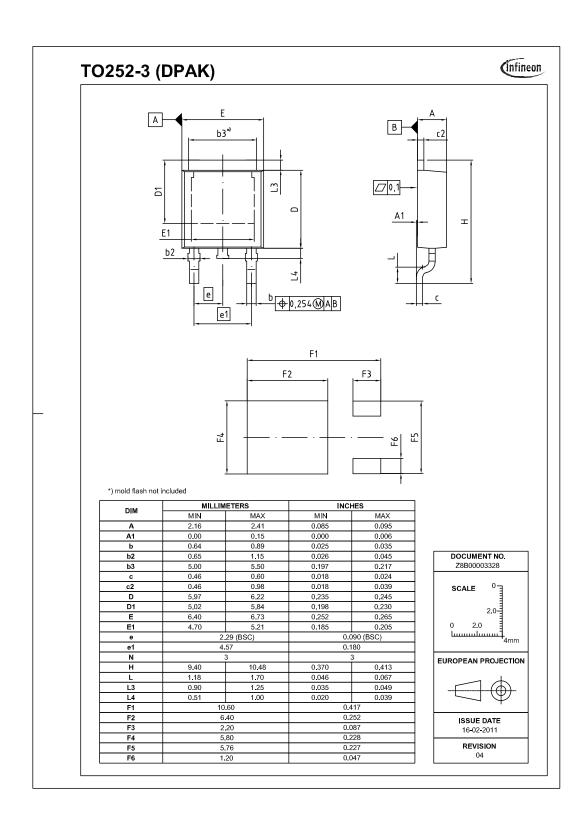


Figure 1 Outline PG-TO252-3, dimensions in mm/inches

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Revision History

IPD046N08N5

Revision: 2020-03-10, Rev. 2.1

Previous Revision

Torrodo Novicion							
Revision	Date	Subjects (major changes since last revision)					
2.0	2016-09-12	Release of final version					
2.1	2020-03-10	Update "Marking"					

Trademarks

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